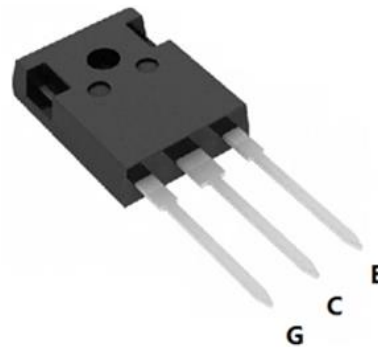
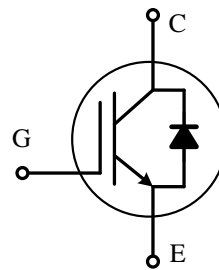


### FEATURES

- High breakdown voltage to 650V for improved reliability
- Trench-Stop Technology offering :
  - High speed switching
  - High ruggedness, temperature stable
  - Short circuit withstand time – 5μs
  - Low  $V_{CEsat}$
  - Easy parallel switching capability due to positive temperature coefficient in  $V_{CEsat}$

$V_{CE}$	<b>650</b>	<b>V</b>
$I_C$	<b>100</b>	<b>A</b>
$V_{CE(SAT)} I_C=100A$	<b>1.95</b>	<b>V</b>



### APPLICATION

- Uninterruptible Power Supplies
- Inverter
- Welding Converters
- PFC applications
- Converter with high switching frequency

Product	Package	Packaging
YGW100N65FSA1	TO247	Tube

**Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-Emitter Breakdown Voltage	$V_{CE}$	650	V
DC collector current, limited by $T_{jmax}$ $T_C = 25^\circ C$ $T_C = 100^\circ C$	$I_C$	200 100	A
Diode Forward current, limited by $T_{jmax}$ $T_C = 25^\circ C$ $T_C = 100^\circ C$	$I_F$	150 75	A
Continuous Gate-emitter voltage	$V_{GE}$	$\pm 20$	V
Transient Gate-emitter voltage ( $t_p \leq 10\mu s, D < 0.01$ )	$V_{GE}$	$\pm 30$	V
Turn off safe operating area $V_{CE} \leq 1200V$ , $T_j \leq 150^\circ C$	-	300	A
Pulsed Collector Current, $V_{GE} = 15V$ , $t_p$ limited by $T_{jmax}$	$I_{CM}$	300	A
Diode Pulsed Current, $t_p$ limited by $T_{jmax}$	$I_{Fpuls}$	225	A
Short Circuit Withstand Time, $V_{GE} = 15V$ , $V_{CE} \leq 600V, T_j = 25^\circ C$	$T_{sc}$	5	$\mu s$
Power dissipation, $T_C = 25^\circ C$	$P_{tot}$	500	W
Max. Junction Temperature (Under switching conditions)	$T_{jmax}$	175	$^\circ C$
Operating junction temperature	$T_{Jop}$	-40...+150	$^\circ C$
Storage temperature	$T_s$	-55...+175	$^\circ C$
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s	-	260	$^\circ C$

**Thermal Resistance**

Parameter	Symbol	Max. Value	Unit
IGBT thermal resistance, junction - case	$R_{\theta(j-c)}$	0.32	K/W
Diode thermal resistance, junction - case	$R_{\theta(j-c)}$	0.8	K/W
Thermal resistance, junction - ambient	$R_{\theta(j-a)}$	40	K/W

**Electrical Characteristics of the IGBT** ( $T_j = 25^\circ\text{C}$  unless otherwise specified) :

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>Static</b>						
Collector-Emitter breakdown voltage	$BV_{CES}$	$V_{GE}=0V, I_C=250\mu A$	650		-	V
Gate threshold voltage	$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C=250\mu A$	4.3	5.3	6.2	V
Collector-Emitter Saturation voltage	$V_{CE(sat)}$	$V_{GE}=15V, I_C=100A$ $T_j = 25^\circ\text{C}$ $T_j = 175^\circ\text{C}$	- -	1.95 2.46	2.3 -	V
Zero gate voltage collector current	$I_{CES}$	$V_{CE} = 1200V, V_{GE} = 0V$ $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	- -	- -	250 2500	$\mu A$
Gate-emitter leakage current	$I_{GES}$	$V_{CE} = 0V, V_{GE} = \pm 20V$	-	-	100	nA
Transconductance	$g_{fs}$	$V_{CE}=20V, I_C=15A$	-	40	-	S

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>Dynamic</b>						
Input capacitance	$C_{ies}$	$V_{CE} = 25V, V_{GE} = 0V,$ $f = 1MHz$	-	4780	-	pF
Output capacitance	$C_{oes}$		-	264	-	
Reverse transfer capacitance	$C_{res}$		-	28	-	
Gate charge total	$Q_g$	$V_{CC} = 520V, I_C = 100A,$ $V_{GE} = 15V$	-	255	-	nC
Gate to emitter charge	$Q_{ge}$		-	37.5	-	
Gate to collector charge	$Q_{gc}$		-	36.5	-	
Short circuit collector current	$I_{C(SC)}$	$V_{GE}=15V, t_{sc} \leq 5\mu s$ $V_{CC}=400V,$ $T_{j, start}=25^\circ\text{C}$	-	500	-	A

**Switching Characteristic, Inductive Load**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>Dynamic</b>						
Turn-on Delay Time	$t_{d(on)}$	$T_j=25^\circ\text{C}$ , $V_{CC} = 400\text{V}$ , $I_C = 100\text{A}$ , $V_{GE} = 0/15\text{V}$ , $R_g=10\Omega$	-	46	-	ns
Rise Time	$t_r$		-	154	-	ns
Turn-off Delay Time	$t_{d(off)}$		-	129	-	ns
Fall Time	$t_f$		-	130	-	ns
Turn-on Energy	$E_{on}$		-	5.4	-	mJ
Turn-off Energy	$E_{off}$		-	3.5	-	mJ
Turn-on Delay Time	$t_{d(on)}$	$T_j=175^\circ\text{C}$ , $V_{CC} = 400\text{V}$ , $I_C = 100\text{A}$ , $V_{GE} = 0/15\text{V}$ , $R_g=10\Omega$	-	42	-	ns
Rise Time	$t_r$		-	200	-	ns
Turn-off Delay Time	$t_{d(off)}$		-	152	-	ns
Fall Time	$t_f$		-	196	-	ns
Turn-on Energy	$E_{on}$		-	7.2	-	mJ
Turn-off Energy	$E_{off}$		-	5.5	-	mJ

**Electrical Characteristics of the DIODE**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>Dynamic</b>						
Diode Forward Voltage	$V_{FM}$	$I_F = 100\text{A}$ $T_j=25^\circ\text{C}$ $T_j=175^\circ\text{C}$	-	2.0 1.8	-	V
Reverse Recovery Time	$T_{rr}$	$T_j=25^\circ\text{C}$	-	125	-	ns
Reverse Recovery Current	$I_{rr}$	$I_F= 100\text{A}$ , $V_R = 400\text{V}$ , $di/dt = 400\text{A}/\mu\text{s}$	-	19.2	-	A
Reverse Recovery Charge	$Q_{rr}$		-	1.14	-	$\mu\text{C}$
Reverse Recovery Time	$T_{rr}$	$T_j=175^\circ\text{C}$	-	201	-	ns
Reverse Recovery Current	$I_{rr}$	$I_F= 100\text{A}$ , $V_R = 400\text{V}$ , $di/dt = 400\text{A}/\mu\text{s}$	-	42.5	-	A
Reverse Recovery Charge	$Q_{rr}$		-	5.0	-	$\mu\text{C}$

Fig. 1 Output characteristics

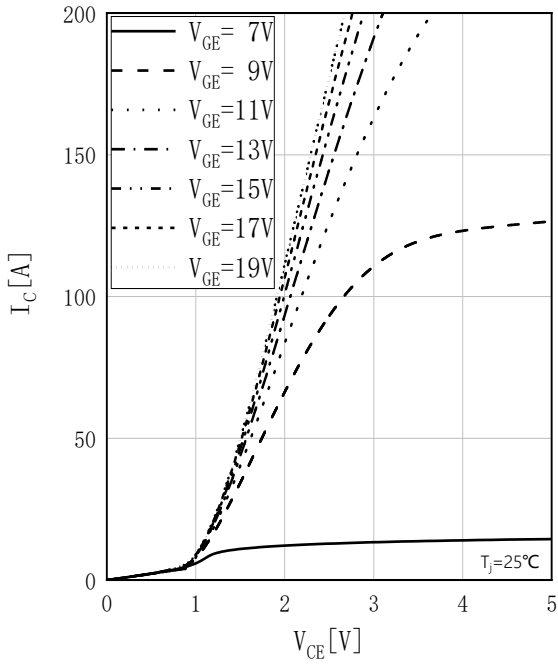


Fig. 2 Output characteristics

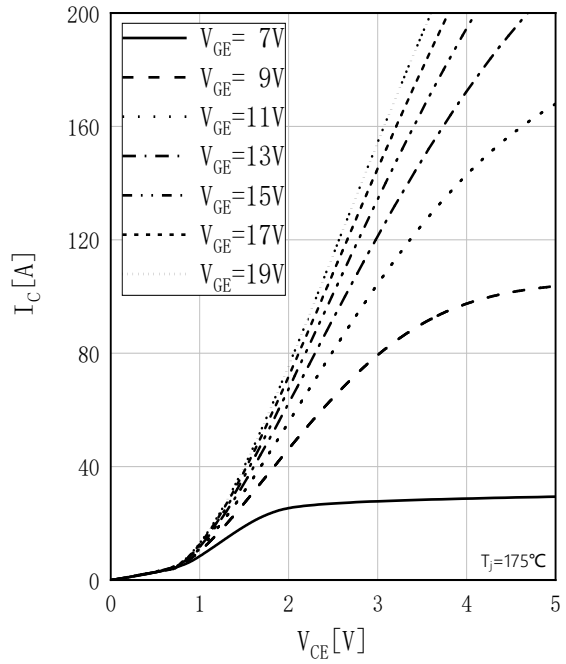


Fig. 3 Saturation voltage characteristics

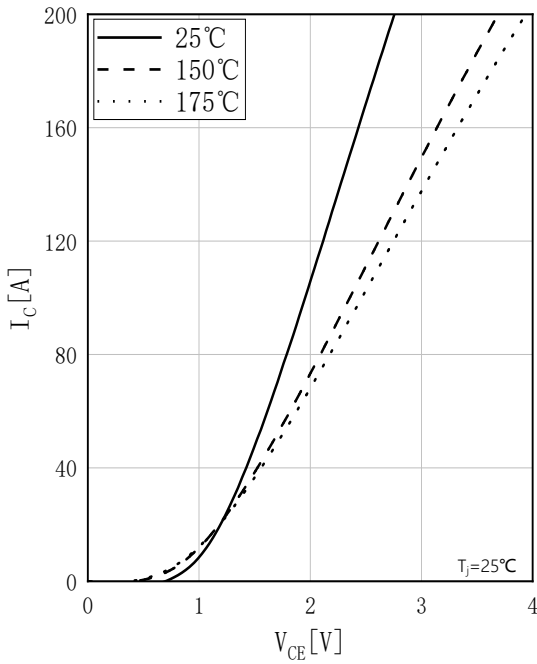


Fig. 4 Transfer characteristics

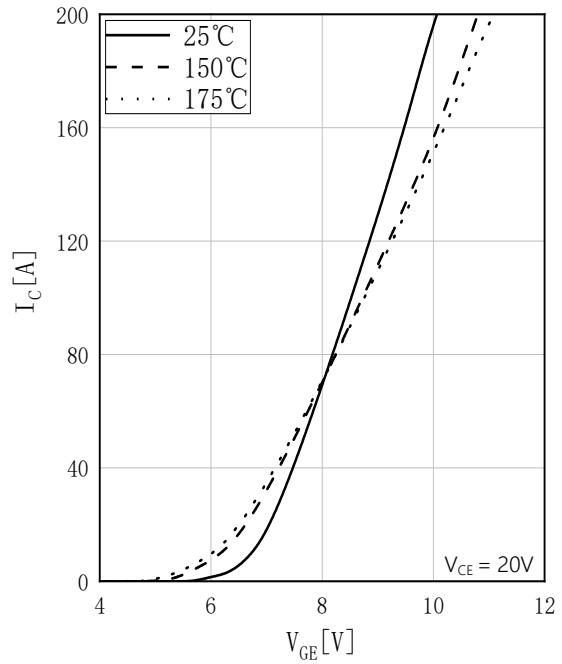


Fig. 5 Switching times vs. gate resistor

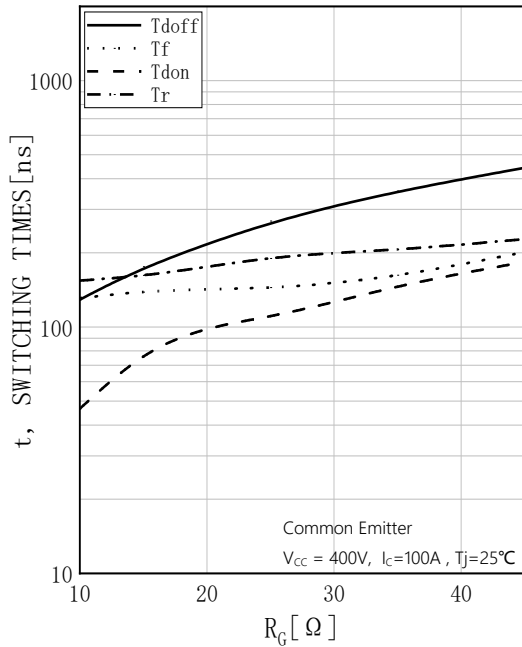


Fig. 6 Switching times vs. collector current

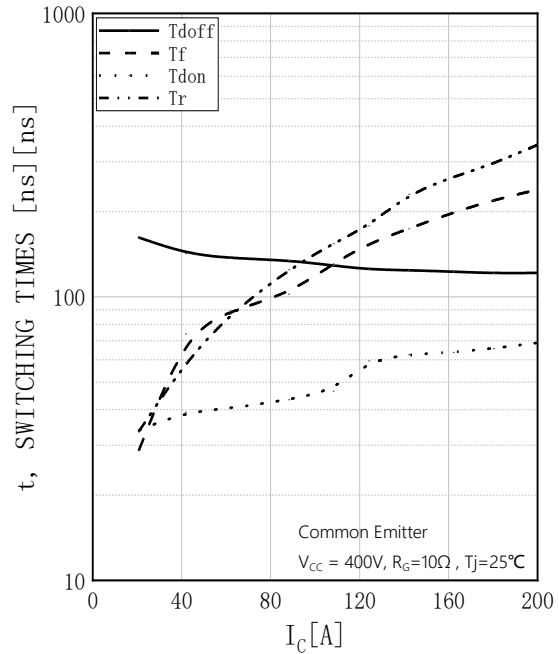


Fig. 7 Switching loss vs. gate resistor

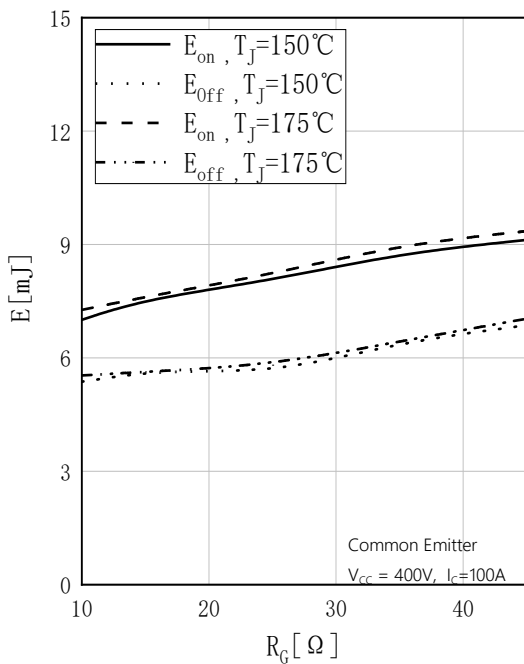


Fig. 8 Switching loss vs. collector current

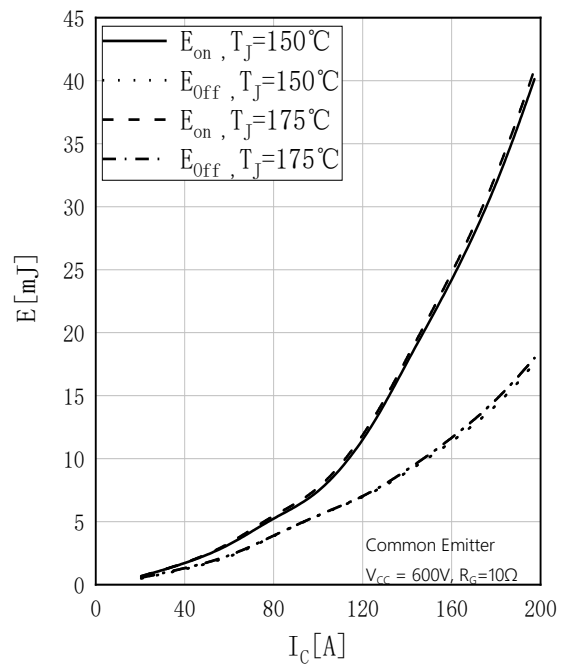


Fig.9 Capacitance characteristics

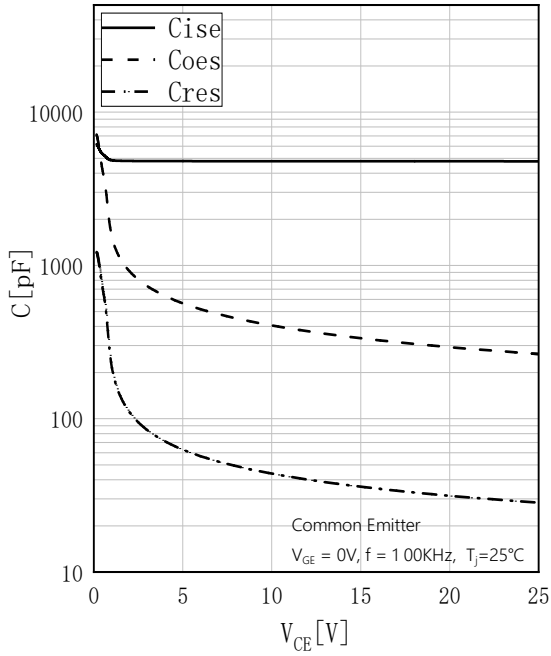


Fig. 10 Gate charge characteristics

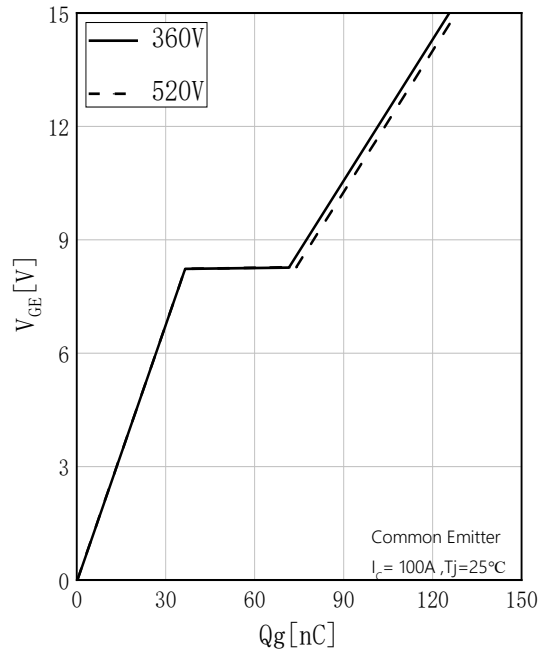


Fig.11 Diode forward current as a function of  $V_f$

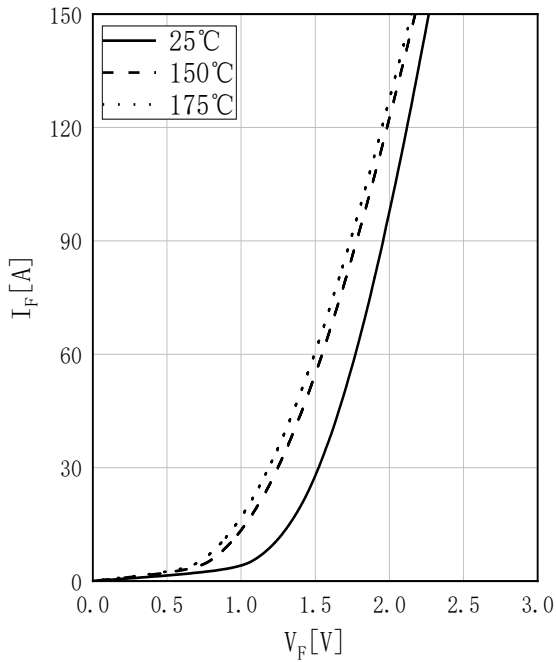
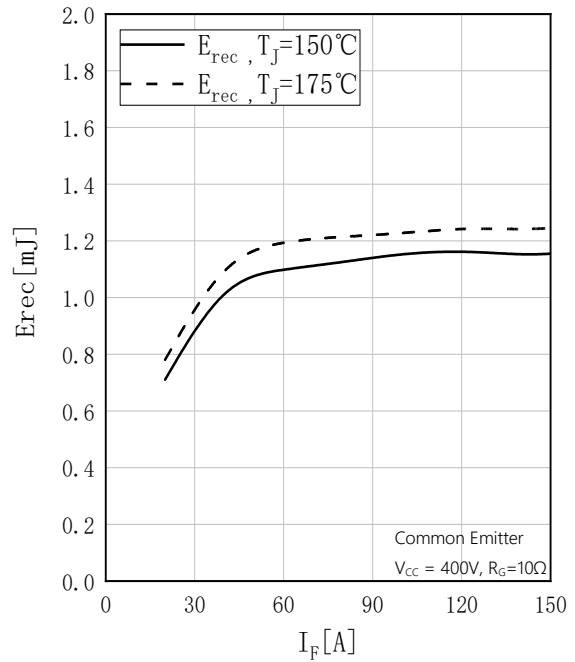
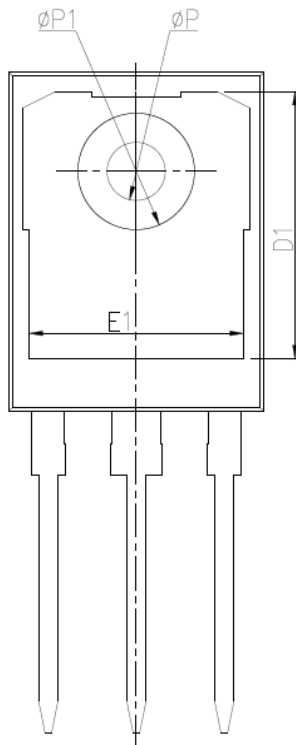
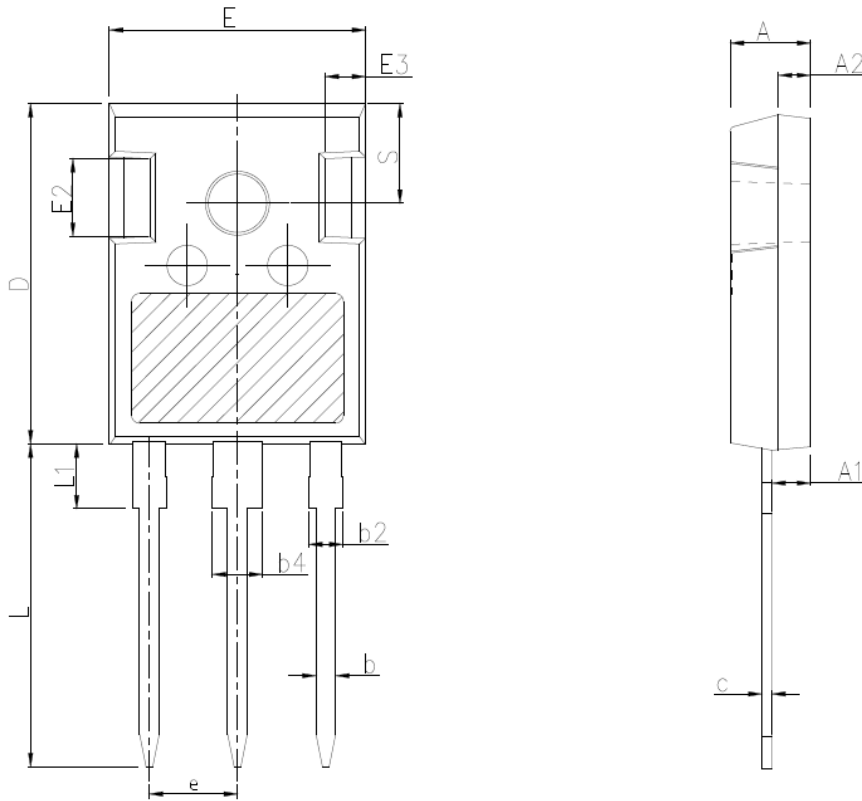


Fig. 12 Typical reverse energy loss vs. forward current



**TO247 package information**



COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.80	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.82	19.92	20.22
L1	-	-	4.30
$\Phi P$	3.40	3.60	3.80
$\Phi P1$	-	-	7.30
S	6.15BSC		